

**Notice of References Cited**

Application/Control No.

10/553,937

Applicant(s)/Patent Under

Reexamination

HIDEK ET AL.

Examiner

Yong Chu

Art Unit

1626

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,448,271	09-2002	Lubisch et al.	514/322
	B	US-			
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**NON-PATENT DOCUMENTS**

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